

Search Notes**Application/Control No.**

09/771,464

Examiner

Hanh Nguyen

Applicant(s)/Patent under Reexamination

VANTTINEN ET AL.

Art Unit

2668

SEARCHED

Class	Subclass	Date	Examiner
370	329	12/20/05	HN
	328		
	331		
	332		
	410		
	426		
	338		
455	422.1		
	404.2		
	412.1		
	456.1		
	456.2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	12/20/2005	HN